

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/767,769	OGAWA, HIDEHIKO	
		Examiner	Art Unit	
		Thomas D. Lee	2624	Page 1 of 1

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	M	US-			

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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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